

ECE 340
Test #1 Review

Problem #1

A silicon sample with $N_D = 10^{16} \text{ cm}^{-3}$ donors is optically excited such that 10^{19} EHP/cm^3 are generated per second uniformly in the sample. The laser causes the sample to heat up to 450 K. The electron and hole lifetimes are both 10^{-6} seconds, $D_p = 12 \text{ cm}^2/\text{s}$; $D_n = 36 \text{ cm}^2/\text{s}$; and $n_i = 10^{14} \text{ cm}^{-3}$ at $T = 450 \text{ K}$. Find the quasi-Fermi levels and the change in the conductivity of the sample upon shining the light.

Problem #2

A portion ($0 \leq x \leq L$) of a silicon sample, uniformly doped with $N_D = 10^{15} \text{ cm}^{-3}$ donors and maintained at room temperature, is subject to a steady state perturbation such that:

$$\begin{aligned}n &\approx N_D \\p &= n_i(1 - x/L) + n_i^2/N_D\end{aligned}$$

Since $n \approx N_D$, it is reasonable to assume that the electric field is approximately equal to zero in the region of interest. Given this, sketch the energy band diagram for the perturbed region specifically including E_c , E_i , E_v , F_n , and F_p on the diagram.

Problem #3

Given a bar-shaped layer of width W , length L , and depth d , and assuming an arbitrary $N_D(x)$ variation with the depth x from the surface of the layer, derive a formula to calculate the resistance of the layer.

Problem #4

The earth is hit by a mysterious ray that momentarily wipes out all minority carriers. Majority carriers are not affected. Initially in equilibrium and not affected by room light, a uniformly doped silicon wafer sitting on your desk is struck by the ray at time $t = 0$. The wafer doping is $N_A = 10^{16} \text{ cm}^{-3}$, $\tau_n = 10^{-6} \text{ s}$, and $T = 300 \text{ K}$.

- What is δn at $t = 0^+$ (i.e. just after time $t = 0$)?
- Does generation or recombination dominate at $t = 0^+$?
- Do low-level injection conditions exist inside the wafer at $t = 0^+$?
- Find a formula for $\delta n(t)$ for $t > 0$.